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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the application of:

Adrian MENZELL et al.

Serial No:

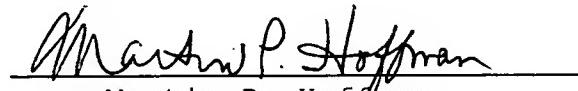
Filed : ATTN: **BOX PCT**For : **EMISSION CONTROL DEVICES**INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

The international search report, dated May 12, 2005, cited six documents of interest. The documents included three U.S. patents, a Canadian patent, a French patent, and a published international application. The six documents are listed on the enclosed PTO Form A820, and copies of the Canadian and French patents are enclosed, along with the published international application. The three U.S. patents are merely listed on the PTO Form A820.

Respectfully submitted,



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May 4, 2006

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INFORMATION DISCLOSURE CITATION
(Use several sheets if necessary)

Docket Number (Optional)

A-10047

Applicant(s)

Adrian MENZELL et al.

Filing Date

Jan. 3, 2007

Group Art Unit

1797

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		3,349,354	10/24/67	Saburo Miyata			
		4,367,143	01/04/83	Carpenter			
		4,568,901	02/04/86	Adam			

U.S. PATENT APPLICATION PUBLICATIONS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						YES	NO
	WO 1993/009868	05/27/93	PCT				
	CA 2169028	08/28/96	Canada				
	FR 2849904	07/16/04	France				

OTHER DOCUMENTS

(Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER

/Richard L. Chiesa/

DATE CONSIDERED

07/02/2008

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.